Search Notes				

Application/Control N .	Applicant(s)/Patent under Reexamination	
10/531,956	MAEDA ET AL.	
Examiner	Art Unit	
TUYEN T. NGUYEN	2832	

SEARCHED			
Class	Subclass	Date	Examiner
336	65, 83, 200, 232	5/29/2006	TTN
			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner ·
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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